



INDIAN SOCIETY FOR NON - DESTRUCTIVE TESTING CHENNAI CHAPTER

The Chairman and Members of the Executive Committee
Cordially invite you for the

JOINT TECHNICAL TALK

ON

1. Industry 4.0 solutions for metal testing in Harsh Environment covering Hardness and flaw detection
2. Flaw detection at high temperature using specialized piezoelectric crystals & monitoring systems

By

**Dr Maria Felice, Product Marketing Manager, Asia region,
Screening Eagle Technologies, Switzerland.**
**Dr William Vickers, Product Manager, Sensors and Systems Solutions,
Ionix Advanced Technologies Ltd., UK.**

ON SUNDAY 23rd May 2021 at 10.00 HRS - 11.15 HRS

Through Microsoft Teams

Requesting members to download Microsoft Teams
and participate via Video Conferencing. More details will be sent on or before 22/05/2021.

Please confirm your participation on or before 21st May 2021.
Only confirmed participants will be invited to join the meeting.

PROGRAMME

10.00 AM	Welcome Address	Shri. S. Subramanian, Chairman
10.05 AM	Introduction to Speakers	Dr. Prabhu Rajagopal, Chairman, Tech. Committee
10.10 AM	Technical Talk	Dr William Vickers
10.35 AM	Technical Talk	Dr Maria Felice
10.55 AM	Q&A	Drs. Vickers & Felice, moderated by ISNT CC
11.10 AM	Vote of Thanks	Shri. P. Anandan, Joint Secretary